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TEST REPORT

EN50665:2017

Report Reference No.: CTL2408147031-WH

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Product Name: ROBOTIC POOL SKIMMER

Model/Type reference: SKS2

List Model(s): N/A

Trade Mark: Aiper

Applicant's name: Shenzhen Aiper Intelligent Co.,Ltd.

Address of applicant: 32nd floor, Block C, Phase 2 Galaxy World, Minle community,
Minzhi street, Longhua district, Shenzhen, China

Test Firm: Shenzhen CTL Testing Technology Co., Ltd.

Address of Test Firm: Zone A, 1/ F, Warehouse 2, Baisha Logistics Company, No. 3011
Shahe West Road, Nanshan District, Shenzhen, Guangdong,
China

Test specification:

Standard: EN50665:2017

TRF Originator: Shenzhen CTL Testing Technology Co., Ltd.

Master TRF: Dated 2011-01

Date of receipt of test item: October 23, 2024

Date of Test Date: October 23, 2024-November 23, 2024

Date of Issue: December 2, 2024

Result: Pass

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TEST REPORT

Test Report No. :	CTL2408147031-WH	December 2, 2024
		Date of issue

Equipment under Test : ROBOTIC POOL SKIMMER

Sample No. CTL2408147031

Model /Type : SKS2

Listed Models : N/A

Applicant : **Shenzhen Aiper Intelligent Co.,Ltd.**

Address : 32nd floor, Block C, Phase 2 Galaxy World, Minle community, Minzhi street, Longhua district, Shenzhen, China

Manufacturer : **Shenzhen Aiper Intelligent Co.,Ltd.**

Address : 32nd floor, Block C, Phase 2 Galaxy World, Minle community, Minzhi street, Longhua district, Shenzhen, China

Test result	Pass *
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* In the configuration tested, the EUT complied with the standards specified page 5.

The test results presented in this report relate only to the object tested.

This report shall not be reproduced, except in full, without the written approval of the issuing testing laboratory.

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1 TEST SUMMARY

1.1 Test Standards

EN62311: Assessment of electronic and electrical equipment related to human exposure restrictions for electromagnetic fields (0 Hz – 300 GHz)

EN50665: Generic standard for assessment of electronic and electrical equipment related to human exposure restrictions for electromagnetic fields (0 Hz - 300 GHz)

Council Recommendation 1999/519/EC of 12 July 1999 on the limitation of exposure of the general public to electromagnetic fields (0Hz to 300GHz) (Official Journal L 197 of 30 July 1999).

1.2 Test Facility

1.2.1 Address of the test laboratory

Shenzhen CTL Testing Technology Co., Ltd.

Zone A, 1/ F, Warehouse 2, Baisha Logistics Company, No. 3011 Shahe West Road, Nanshan District, Shenzhen, Guangdong, China

There is one 3m semi-anechoic chamber and two line conducted labs for final test. The Test Sites meet the requirements in documents ANSI C63.4 and CISPR 32/EN 55032 requirements.

1.2.2 Laboratory accreditation

The test facility is recognized, certified, or accredited by the following organizations:

CNAS-Lab Code: L7497

Shenzhen CTL Testing Technology Co., Ltd. has been assessed and proved to be in compliance with CNAS-CL01 Accreditation Criteria for Testing and Calibration Laboratories (identical to ISO/IEC 17025: 2017 General Requirements) for the Competence of Testing and Calibration Laboratories.

A2LA-Lab Cert. No. 4343.01

Shenzhen CTL Testing Technology Co., Ltd. EMC Laboratory has been accredited by A2LA for technical competence in the field of electrical testing, and proved to be in compliance with ISO/IEC 17025: 2017 General Requirements for the Competence of Testing and Calibration Laboratories and any additional program requirements in the identified field of testing.

IC Registration No.: 9618B

CAB identifier: CN0041

The 3m alternate test site of Shenzhen CTL Testing Technology Co., Ltd. EMC Laboratory has been registered by Innovation, Science and Economic Development Canada to test to Canadian radio equipment requirements with Registration No.: 9618B.

FCC-Registration No.: 399832

Designation No.: CN1216

Shenzhen CTL Testing Technology Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the (FCC) Federal Communications Commission. The acceptance letter from the FCC is maintained in our files. Registration 399832.

1.3 Statement of the measurement uncertainty

The data and results referenced in this document are true and accurate. The reader is cautioned that there may be errors within the calibration limits of the equipment and facilities. The measurement uncertainty was calculated for all measurements listed in this test report acc. to CISPR 16-4 Specification for radio disturbance and immunity measuring apparatus and methods – Part 4: Uncertainty in EMC Measurements“ and is documented in the Shenzhen CTL Testing Technology Co., Ltd. quality system acc. to DIN EN ISO/IEC 17025. Furthermore, component and process variability of devices similar to that tested may result in additional deviation. The manufacturer has the sole responsibility of continued compliance of the device.

Hereafter the best measurement capability for CTL laboratory is reported:

Test Items	Measurement Uncertainty	Notes
Occupied Channel Bandwidth	$\pm 2\%$	(1)
Transmitter power conducted	0.57 dB	(1)
Transmitter power Radiated	2.20 dB	(1)
Conducted spurious emission	1.60 dB	(1)
Radiated spurious emission	2.20 dB	(1)
Temperature	$\pm 1^{\circ}\text{C}$	(1)
Humidity	$\pm 3\%$	(1)
DC and low frequency voltages	$\pm 1.5\%$	(1)
Time	$\pm 2\%$	(1)
Duty cycle	$\pm 2\%$	(1)
RF output power	± 1.18 dB	(1)
Power Spectral Density	± 1.51 dB	(1)
Duty Cycle	$\pm 0.11\%$	(1)
Tx-sequence	$\pm 0.11\%$	(1)
Tx-gap	$\pm 0.11\%$	(1)
Medium Utilisation (MU) factor	$\pm 1.18\%$	(1)
Dwell time	$\pm 0.11\%$	(1)
Minimum Frequency Occupation	$\pm 1.9\%$	(1)
Hopping Sequence	$\pm 1.9\%$	(1)
Hopping Frequency Separation	$\pm 1.9\%$	(1)
Occupied Channel Bandwidth	$\pm 1.9\%$	(1)
Transmitter unwanted emissions in the out-of-band domain	± 1.21 dB	(1)
Transmitter unwanted emissions in the spurious domain	9kHz-7GHz: ± 1.09 dB 7GHz-26.5GHz: ± 3.27 dB	(1)
Receiver spurious emissions	9kHz-7GHz: ± 1.09 dB 7GHz-26.5GHz: ± 3.27 dB	(1)
Adaptivity	$\pm 1.17\%$	(1)
Receiver Blocking	$\pm 2.69\%$	(1)

Note 1: This uncertainty represents an expanded uncertainty expressed at approximately the 95% confidence level using a coverage factor of $k=1.96$.

2 GENERAL INFORMATION

2.1 Environmental conditions

During the measurement the environmental conditions were within the listed ranges:

Normal Temperature:	25°C -35°C
Relative Humidity	35%-55 %
Air Pressure	101KPa

2.2 General Description of EUT

Product Name:	ROBOTIC POOL SKIMMER
Model/Type reference:	SKS2
Power supply:	AC100-240V~ 50/60Hz 0.4A from adapter or DC 10.8V from battery
Adapter information	Model: GQ12-126100-HG Input: 100-240V~50/60Hz 0.4A Output: 12.6V --- 1.0A 12.6W
Bluetooth Low Energy	
Supported type:	Bluetooth Low Energy
Modulation:	GFSK
Operation frequency:	2402MHz~2480MHz
Channel number:	40
Channel separation:	2MHz
Antenna type:	FPC Antenna
Antenna gain:	1.06dBi
2.4G Wi-Fi	
Supported type:	IEEE 802.11 b/g/n
Modulation:	IEEE 802.11 b: DSSS IEEE 802.11 g/IEEE 802.11 n(HT20)/IEEE 802.11 n(HT40): OFDM
Operation frequency:	IEEE 802.11 b/IEEE 802.11 g/IEEE 802.11 n(HT20): 2412MHz~2472MHz IEEE 802.11 n(HT40): 2422MHz~2462MHz
Channel number:	IEEE 802.11 b/IEEE 802.11 g/IEEE 802.11 n(HT20): 13 IEEE 802.11 n(HT40): 11
Channel separation:	5MHz
Antenna type:	FPC Antenna
Antenna gain:	1.06dBi

Note 1: For more detailed features description, please refer to the manufacturer's specifications or the User's Manual.

Note 2: Antenna gain provided by the applicant.

3 Method of measurement

Limit

Basic restriction for electric, magnetic and electromagnetic fields (0Hz to 300GHz)

Frequency range	Magnetic flux density (mT)	Current density (mA/m ²)	Whole body average SAR(W/kg)	Localised SAR (head and trunk)(W/kg)	Localised SAR (limbs) (W/kg)	Power density, S (W/m ²)
0Hz	40	--	--	--	--	--
>0-1Hz	--	8	--	--	--	--
1-4Hz	--	8/f	--	--	--	--
4-1000Hz	--	2	--	--	--	--
1000Hz-100kHz	--	f/500	--	--	--	--
100kHz-10MHz	--	f/500	0.08	2	4	--
10MHz-10GHz	--	--	0.08	2	4	--
10-300GHz	--	--	--	--	--	10

Notes:

1. f is the frequency in Hz.
2. The basic restriction on the current density is intended to protect against acute exposure effects on central nervous system tissues in the head and trunk of the body and includes a safety factor. The basic restrictions for ELF fields are based on established adverse effects on the central nervous system. Such acute effects are essentially instantaneous and there is no scientific justification to modify the basic restrictions for exposure of short duration. However, since the basic restriction refers to adverse effects on the central nervous system, this basic restriction may permit higher current densities in body tissues other than the central nervous system under the same exposure conditions.
3. Because of electrical inhomogeneity of the body, current densities should be averaged over a cross section of 1cm² perpendicular to the current direction.
4. For frequencies up to 100 kHz, peak current density values can be obtained by multiplying the rms value by $\sqrt{2}$ (=1.414). For pulses of duration t_p the equivalent frequency to apply in the basic restrictions should be calculated as $f = 1/(2t_p)$.
5. For frequencies up to 100kHz and for pulsed magnetic fields, the maximum current density associated with the pulses can be calculated from the rise/fall times and the maximum rate of change of magnetic flux density. The induced current density can then be compared with the appropriate basic restriction.
6. All SAR values are to be averaged over any six-minute period.
7. Localised SAR averaging mass is any 10g of contiguous tissue; the maximum SAR so obtained should be the value used for the estimation of exposure. These 10g of tissue are intended to be a mass of contiguous tissue with nearly homogeneous electrical properties. In specifying a contiguous mass of tissue, it is recognised that this concept can be used in computational dosimetry but may present difficulties for direct physical measurements. A simple geometry such as cubic tissue mass can be used provided that the calculated dosimetric quantities have conservation values relative to the exposure guidelines.
8. For pulses of duration t_p the equivalent frequency to apply in the basic restrictions should be calculated as $f = 1/(2t_p)$. Additionally, for pulsed exposures, in the frequency range 0,3 to 10GHz and for localised exposure of the head, in order to limit and avoid auditory effects caused by thermoelastic expansion, an additional basic restriction is recommended. This is that SA should not exceed 2mJ kg⁻¹ averaged over 10g of tissue.

Reference levels for electric, magnetic and electromagnetic fields (0Hz to 300GHz, unperturbed rms values)

Frequency range	E-field strength (V/m)	H-field strength (A/m)	B-field (uT)	Equivalent plane wave power density S_{eq} (W/m ²)
0-1Hz	--	3.2×10^4	4×10^4	--
1-8Hz	10000	$3.2 \times 10^4 / f^2$	$4 \times 10^4 / f^2$	--
8-25Hz	10000	4000/f	5000/f	--
0.025-0.8KHz	250/f	4/f	5/f	--
0.8-3KHz	250/f	5	6.25	--
3-150KHz	87	5	6.25	--
0.15-1MHz	87	0.73/f	0.92/f	--
1-10MHz	$87/f^{1/2}$	0.73/f	0.92/f	--
10-400MHz	28	0.073	0.092	2
400-2000MHz	$1.375f^{1/2}$	$0.0037f^{1/2}$	$0.0046f^{1/2}$	f/200
2-300GHz	61	0.16	0.20	10

Notes: 1. As indicated in the frequency range column.

2. For frequencies between 100kHz and 10GHz, S_{eq} , E^2 , H^2 and B^2 are to be averaged over any six-minute period.

3. For frequencies exceeding 10GHz, S_{eq} , E^2 , H^2 and B^2 are to be averaged over any $68/f^{1.05}$ -minute period (.in GHz).

4. No E-field value is provided for frequencies <1Hz, which are effectively static electric fields. For most people the annoying perception of surface electric charges will not occur at field strengths less than 20kV/m. Spark discharges causing stress or annoyance should be avoided.

EMF Assessment Model

Predication of EMF limit at a given distance

Equation from page 26 of EN 62311, Edition 2008

$$E = \eta_0 H = \frac{\sqrt{30PG(\theta, \phi)}}{r}$$

Where:

E: E-field strength (V/m)

P: power input to antenna (Watt)

G: is the antenna gain relative to an isotropic antenna;

θ, ϕ : are elevation and azimuth angles to point of investigation;

r: is the distance from observation point to the antenna;

η_0 : is the characteristic impedance of free space.

Test Result

From the maximum EUT RF output power, the minimum mobile separation distance, $r=20\text{cm}$.

According to the test report No.: CTL2401058291-WR01 & CTL2401058291-WR02 the power against the limit as follow:

Bluetooth Low Energy

Test Frequency (MHz)	Minimum Separation Distance (cm)	Output Power (dBm)	Output Power (W)	Antenna Gain (dBi)	E-field strength Limit (V/m)	E-field strength At 20 cm (V/m)
2402	20	1.16	0.0013	1.2764	61	1.1182

2.4G Wi-Fi

Test Frequency (MHz)	Minimum Separation Distance (cm)	Output Power (dBm)	Output Power (W)	Antenna Gain (dBi)	E-field strength Limit (V/m)	E-field strength At 20 cm (V/m)
2442	20	17.38	0.0547	1.2764	61	7.2365

Note: Only worst case reported

***** End of Report *****